
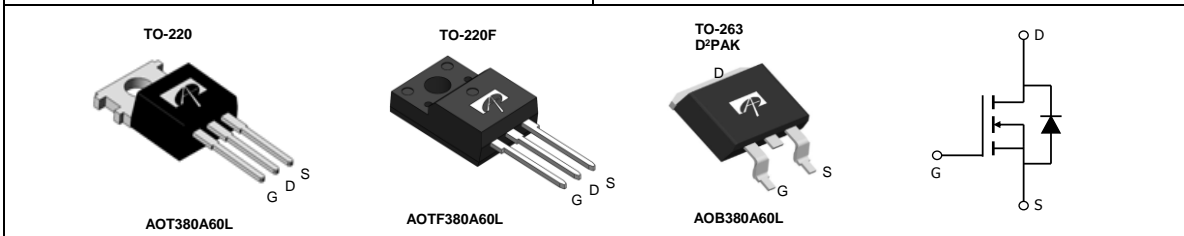


|  |  |                      |      |          |     |                  |                 |             |      |                  |             |
|--|--|----------------------|------|----------|-----|------------------|-----------------|-------------|------|------------------|-------------|
| <b>General Description</b> <ul style="list-style-type: none"> <li>• Proprietary <math>\alpha</math>MOS5™ technology</li> <li>• Low <math>R_{DS(ON)}</math></li> <li>• Optimized switching parameters for better EMI performance</li> <li>• Enhanced body diode for robustness and fast reverse recovery</li> </ul><br><b>Applications</b> <ul style="list-style-type: none"> <li>• SMPS with PFC, Flyback and LLC topologies</li> <li>• Silver ATX ,adapter, TV, lighting, Server power</li> </ul> | <b>Product Summary</b> <table border="0"> <tr> <td><math>V_{DS} @ T_{j,max}</math></td> <td>700V</td> </tr> <tr> <td><math>I_{DM}</math></td> <td>44A</td> </tr> <tr> <td><math>R_{DS(ON),max}</math></td> <td>&lt; 0.38<math>\Omega</math></td> </tr> <tr> <td><math>Q_{g,typ}</math></td> <td>18nC</td> </tr> <tr> <td><math>E_{oss} @ 400V</math></td> <td>2.6<math>\mu</math>J</td> </tr> </table><br>100% UIS Tested<br>100% $R_g$ Tested <div style="text-align: right;">  </div> | $V_{DS} @ T_{j,max}$ | 700V | $I_{DM}$ | 44A | $R_{DS(ON),max}$ | < 0.38 $\Omega$ | $Q_{g,typ}$ | 18nC | $E_{oss} @ 400V$ | 2.6 $\mu$ J |
| $V_{DS} @ T_{j,max}$   | 700V   |                      |      |          |     |                  |                 |             |      |                  |             |
| $I_{DM}$   | 44A  |                      |      |          |     |                  |                 |             |      |                  |             |
| $R_{DS(ON),max}$   | < 0.38 $\Omega$  |                      |      |          |     |                  |                 |             |      |                  |             |
| $Q_{g,typ}$  | 18nC   |                      |      |          |     |                  |                 |             |      |                  |             |
| $E_{oss} @ 400V$   | 2.6 $\mu$ J  |                      |      |          |     |                  |                 |             |      |                  |             |



| Orderable Part Number | Package Type  | Form          | Minimum Order Quantity |
|-----------------------|---------------|---------------|------------------------|
| AOT380A60L            | TO-220 Green  | Tube          | 1000                   |
| AOTF380A60L           | TO-220F Green | Tube          | 1000                   |
| AOB380A60L            | TO263         | Tape and reel | 800                    |

| Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted  |                         |               |             |       |
|---|-------------------------|---------------|-------------|-------|
| Parameter   | Symbol                  | AOT(B)380A60L | AOTF380A60L | Units |
| Drain-Source Voltage  | $V_{DS}$                | 600           |             | V     |
| Gate-Source Voltage   | $V_{GS}$                | $\pm 20$      |             | V     |
| Gate-Source Voltage (dynamic) AC (f>1Hz)  | $V_{GS}$                | $\pm 30$      |             | V     |
| Continuous Drain Current  | $T_C=25^\circ\text{C}$  | 11            | 11*         | A     |
|   | $T_C=100^\circ\text{C}$ | 7.2           | 7.2*        |       |
| Pulsed Drain Current <sup>C</sup>   | $I_{DM}$                | 44            |             | A     |
| Avalanche Current <sup>C</sup>  | $I_{AR}$                | 2.5           |             | A     |
| Repetitive avalanche energy <sup>C</sup>  | $E_{AR}$                | 3.1           |             | mJ    |
| Single pulsed avalanche energy <sup>G</sup> ( $T_J=25^\circ\text{C}$ , $V_{GS}=10\text{V}$ , $I_L=2\text{A}$ , $L=105\text{mH}$ , $R_{GS}=25\Omega$ ) | $E_{AS}$                | 210           |             | mJ    |
| MOSFET dv/dt ruggedness   | dv/dt                   | 100           |             | V/ns  |
| Peak diode recovery dv/dt   | dv/dt                   | 20            |             | V/ns  |
| Power Dissipation <sup>B</sup>  | $T_C=25^\circ\text{C}$  | 131           | 27          | W     |
|   | Derate above 25°C       | 1.0           | 0.2         | W/°C  |
| Junction and Storage Temperature Range  | $T_J, T_{ST}$           | -55 to 150    |             | °C    |
| Maximum lead temperature for soldering purpose, 1/8" from case for 5 seconds  | $T_L$                   | 300           |             | °C    |

| Thermal Characteristics                    |                 |               |             |       |
|--|-----------------|---------------|-------------|-------|
| Parameter                                  | Symbol          | AOT(B)380A60L | AOTF380A60L | Units |
| Maximum Junction-to-Ambient <sup>A,D</sup> | $R_{\theta JA}$ | 65            | 65          | °C/W  |
| Maximum Case-to-sink <sup>A</sup>          | $R_{\theta CS}$ | 0.5           | --          | °C/W  |
| Maximum Junction-to-Case                   | $R_{\theta JC}$ | 0.95          | 4.6         | °C/W  |

\* Drain current limited by maximum junction temperature.

**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                             | Parameter   | Conditions   | Min | Typ  | Max  | Units |
|------------------------------------|---|--|-----|------|------|-------|
| <b>STATIC PARAMETERS</b>           |   |  |     |      |      |       |
| BV <sub>DSS</sub>                  | Drain-Source Breakdown Voltage                            | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C                         | 600 |      |      | V     |
|                                    |   | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V, T <sub>J</sub> =150°C                        |     | 700  |      |       |
| BV <sub>DSS</sub> /ΔT <sub>J</sub> | Breakdown Voltage Temperature Coefficient                 | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V   |     | 0.44 |      | V/°C  |
| I <sub>DSS</sub>                   | Zero Gate Voltage Drain Current                           | V <sub>DS</sub> =600V, V <sub>GS</sub> =0V   |     |      | 1    | μA    |
|                                    |   | V <sub>DS</sub> =480V, T <sub>J</sub> =125°C   |     |      | 10   |       |
| I <sub>GSS</sub>                   | Gate-Body leakage current                                 | V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V   |     |      | ±100 | nA    |
| V <sub>GS(th)</sub>                | Gate Threshold Voltage                                    | V <sub>DS</sub> =5V, I <sub>D</sub> =250μA   | 2.6 | 3.2  | 3.8  | V     |
| R <sub>DS(ON)</sub>                | Static Drain-Source On-Resistance                         | V <sub>GS</sub> =10V, I <sub>D</sub> =5.5A   |     | 0.33 | 0.38 | Ω     |
| g <sub>FS</sub>                    | Forward Transconductance                                  | V <sub>DS</sub> =10V, I <sub>D</sub> =5.5A   |     | 9.3  |      | S     |
| V <sub>SD</sub>                    | Diode Forward Voltage                                     | I <sub>S</sub> =5.5A, V <sub>GS</sub> =0V  |     | 0.85 | 1.2  | V     |
| I <sub>S</sub>                     | Maximum Body-Diode Continuous Current                     |  |     |      | 11   | A     |
| I <sub>SM</sub>                    | Maximum Body-Diode Pulsed Current <sup>C</sup>            |  |     |      | 44   | A     |
| <b>DYNAMIC PARAMETERS</b>          |   |  |     |      |      |       |
| C <sub>iss</sub>                   | Input Capacitance   | V <sub>GS</sub> =0V, V <sub>DS</sub> =100V, f=1MHz                                       |     | 955  |      | pF    |
| C <sub>oss</sub>                   | Output Capacitance  |  |     | 29   |      | pF    |
| C <sub>o(er)</sub>                 | Effective output capacitance, energy related <sup>H</sup> | V <sub>GS</sub> =0V, V <sub>DS</sub> =0 to 480V, f=1MHz                                  |     | 30   |      | pF    |
| C <sub>o(tr)</sub>                 | Effective output capacitance, time related <sup>I</sup>   |  |     | 122  |      | pF    |
| C <sub>rss</sub>                   | Reverse Transfer Capacitance                              | V <sub>GS</sub> =0V, V <sub>DS</sub> =100V, f=1MHz                                       |     | 2.4  |      | pF    |
| R <sub>g</sub>                     | Gate resistance   | f=1MHz   |     | 4.8  |      | Ω     |
| <b>SWITCHING PARAMETERS</b>        |   |  |     |      |      |       |
| Q <sub>g</sub>                     | Total Gate Charge   | V <sub>GS</sub> =10V, V <sub>DS</sub> =480V, I <sub>D</sub> =5.5A                        |     | 18   |      | nC    |
| Q <sub>gs</sub>                    | Gate Source Charge  |  |     | 7    |      | nC    |
| Q <sub>gd</sub>                    | Gate Drain Charge   |  |     | 4.5  |      | nC    |
| t <sub>D(on)</sub>                 | Turn-On DelayTime   | V <sub>GS</sub> =10V, V <sub>DS</sub> =400V, I <sub>D</sub> =5.5A,<br>R <sub>G</sub> =5Ω |     | 20   |      | ns    |
| t <sub>r</sub>                     | Turn-On Rise Time   |  |     | 13   |      | ns    |
| t <sub>D(off)</sub>                | Turn-Off DelayTime  |  |     | 43   |      | ns    |
| t <sub>f</sub>                     | Turn-Off Fall Time  |  |     | 16   |      | ns    |
| t <sub>rr</sub>                    | Body Diode Reverse Recovery Time                          |  |     | 251  |      | ns    |
| I <sub>rm</sub>                    | Peak Reverse Recovery Current                             | I <sub>F</sub> =5.5A, di/dt=100A/μs, V <sub>DS</sub> =400V                               |     | 19   |      | A     |
| Q <sub>rr</sub>                    | Body Diode Reverse Recovery Charge                        |  |     | 3.1  |      | μC    |

A. The value of R<sub>θJA</sub> is measured with the device in a still air environment with T<sub>A</sub>=25° C.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150° C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub>=25° C.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating.

G. This is the absolute maximum rating. Parts are 100% tested at T<sub>J</sub>=25° C, L=60mH, I<sub>AS</sub>=1A, V<sub>DD</sub>=150V, R<sub>G</sub>=25Ω.

H. C<sub>o(er)</sub> is a fixed capacitance that gives the same stored energy as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>(BR)DSS</sub>.

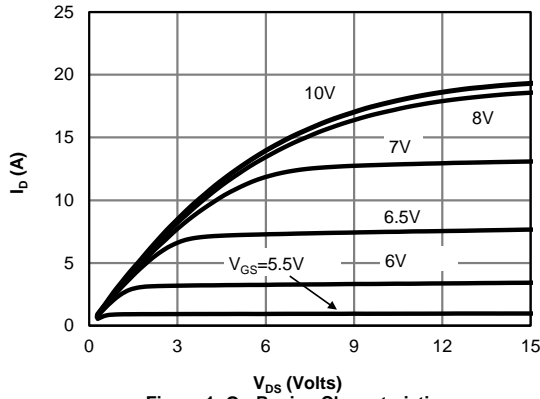
I. C<sub>o(tr)</sub> is a fixed capacitance that gives the same charging time as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>(BR)DSS</sub>.

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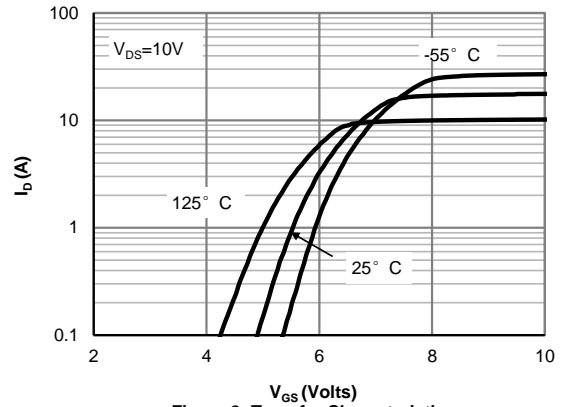
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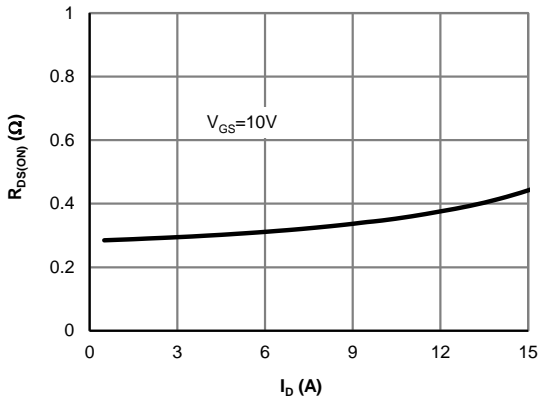
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



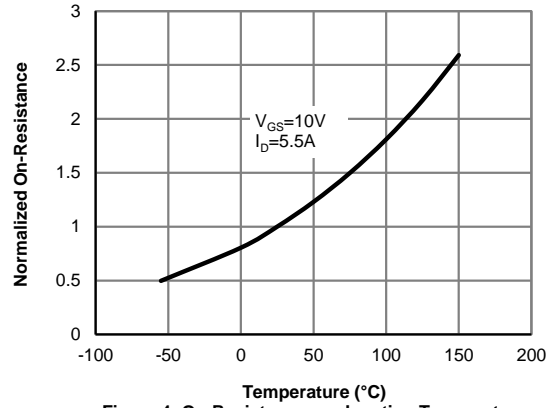
**Figure 1: On-Region Characteristics**



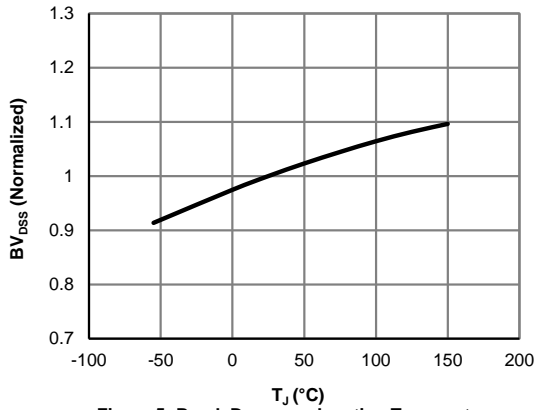
**Figure 2: Transfer Characteristics**



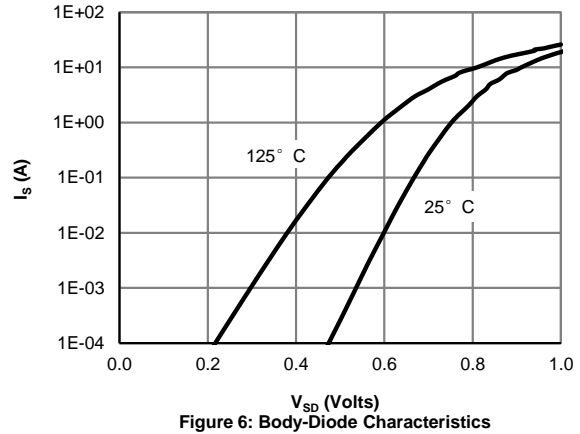
**Figure 3: On-Resistance vs. Drain Current and Gate Voltage**



**Figure 4: On-Resistance vs. Junction Temperature**

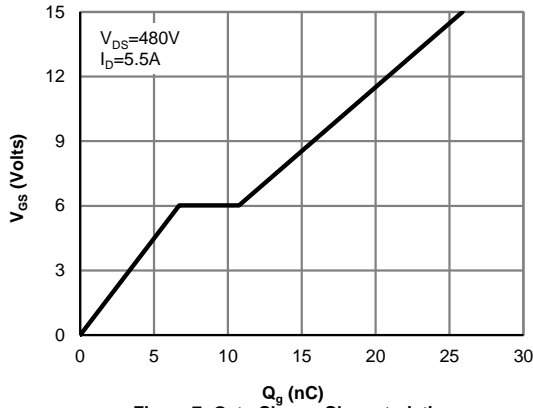


**Figure 5: Break Down vs. Junction Temperature**

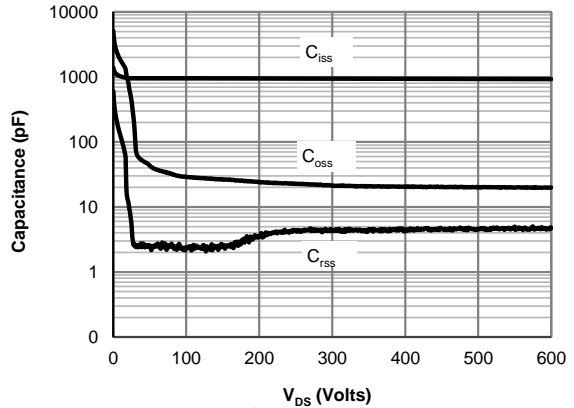


**Figure 6: Body-Diode Characteristics**

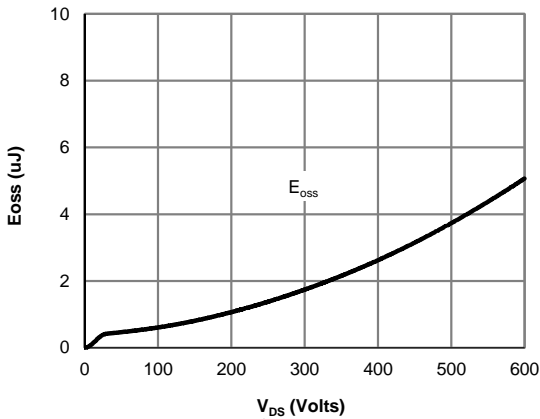
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



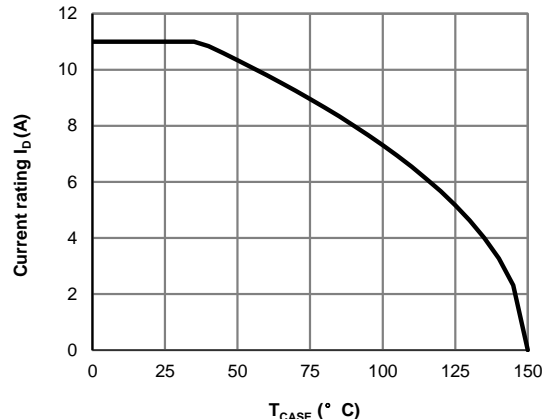
**Figure 7: Gate-Charge Characteristics**



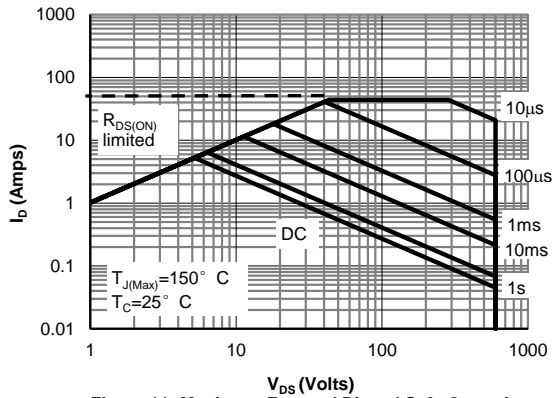
**Figure 8: Capacitance Characteristics**



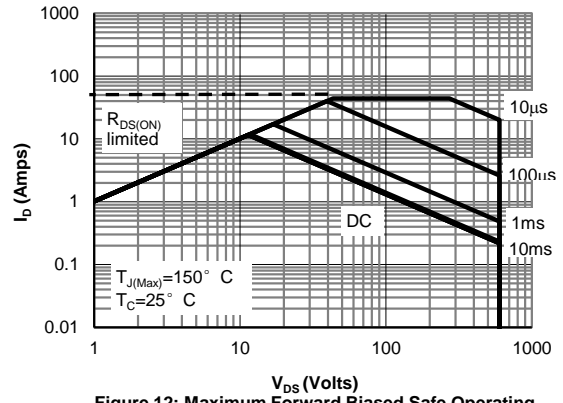
**Figure 9: Coss stored Energy**



**Figure 10: Current De-rating (Note F)**

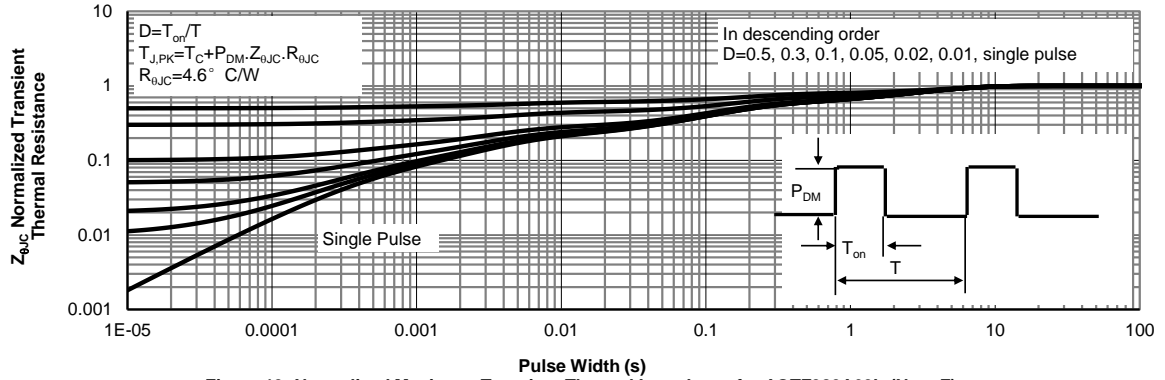


**Figure 11: Maximum Forward Biased Safe Operating Area for AOTF380A60L (Note F)**

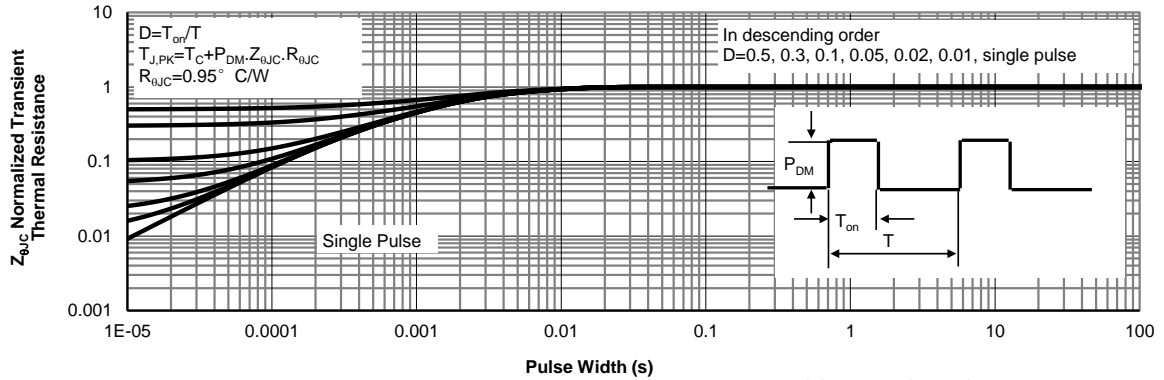


**Figure 12: Maximum Forward Biased Safe Operating Area for AOT(B)380A60L (Note F)**

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

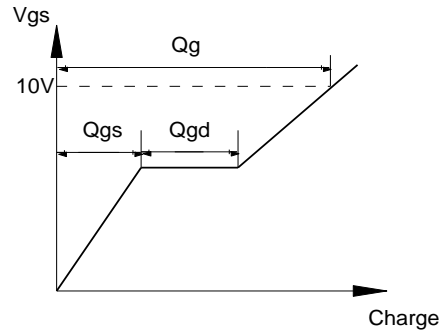
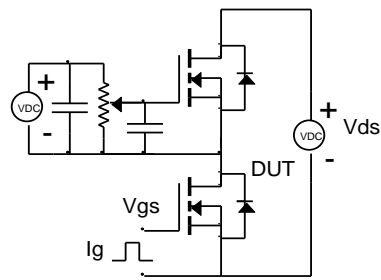


**Figure 13: Normalized Maximum Transient Thermal Impedance for AOTF380A60L (Note F)**

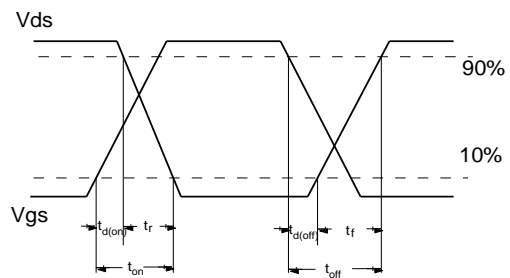
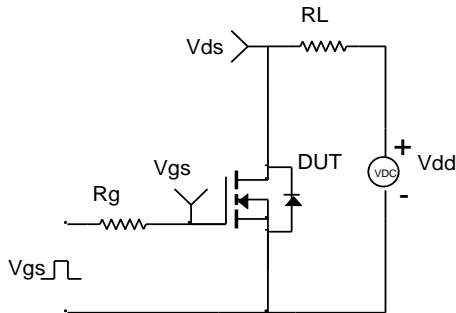


**Figure 14: Normalized Maximum Transient Thermal Impedance for AOT(B)380A60L (Note F)**

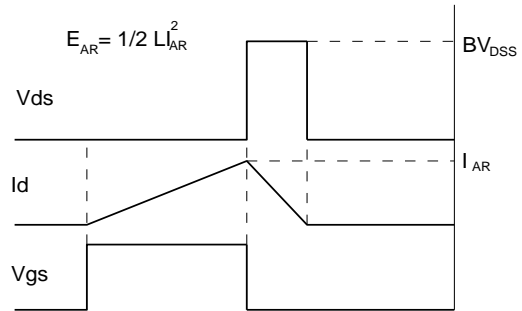
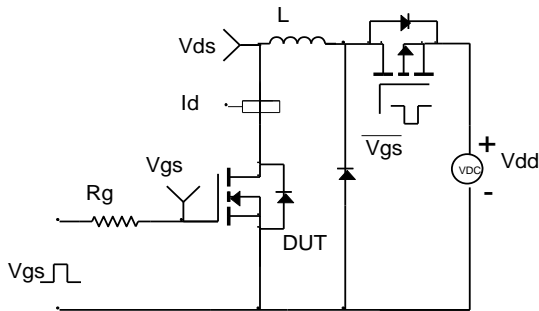
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

